

Form 1449 (Modified)

**Information Disclosure
Statement By Applicant**

(Use Several Sheets if Necessary)

Atty Docket No.:

IMM1P069D

Applicant:

Schuler et al.

Filing Date:

8/14/00

Application No.:

09/638,485

Group:

2837

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
TS	A	4,937,685	6/26/90	Barker et al.	360-	14.1	12/2/83
TS	B	4,964,004	10/16/90	Barker	360	14.1	6/16/89
TS	C	4,0983,901	1/8/91	Lehmer	318	685	4/21/89
TS	D	5,076,517	12/31/91	Ferranti et al.	244	228	8/14/89
TS	E	5,184,319	2/2/93	Kramer	364	806	2/2/90
TS	F	5,286,203	2/15/94	Fuller et al.	434	45	10/7/92
TS	G	5,354,162	10/11/94	Burdea et al.	414	5	8/31/92
TS	H	5,428,748	6/27/95	Davidson et al.	395	275	9/24/92
TS	I	5,634,794	6/3/97	Hildreth et al.	434	37	3/23/95
TS	J	5,742,278	4/21/98	Chen et al.	345	156	11/1/95
TS	K	5,781,172	7/14/98	Engel et al.	345	164	6/16/97

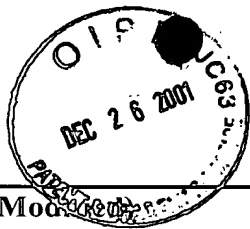
Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
TS	L	0085518	10.08.83	EPO			X	
TS	M	0111992	27.06.84	EPO			X	
TS	N	0349086	03.01.90	EPO			X	
TS	O	2235310	27.02.91	GB			X	
TS	P	0326439	2.8.89	EPO				

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
TS	R	Flight Simulation, Rolfe, J.M. and Staples, K. J., eds., 1986.
	S	
	T	
Examiner <i>Deane Smith</i>		Date Considered <i>5/13/02</i>

Examiner Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Form 1449 (Mod 100) Information Disclosure Statement By Applicant (Use Several Sheets if Necessary)	Atty Docket No.: IMM1P069D	Application No.: 09/638,485
	Applicant: Schuler et al. Filing Date: 8/14/00	Group: 2837

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
TS	A	5,999,168	12/7/99	Rosenberg et al.	345	161	2/21/97
TS	B	6,088,017	7/11/00	Tremblay et al.	345	156	4/24/98
	C						
	D						
	E						
	F						
	G						
	H						
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	J						
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Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
TS	L	95/20788	3.8.95	PCT			X	
TS	M	0626634	30.11.94	EPO			X	
TS	N	H6-210065	2.8.94	Japan			X	
TS	O	H4-92691	25.3.92	Japan			X	
TS	P	H5-86387	22.11.93	Japan			X	

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	R	
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	T	
Examiner	Date Considered	
<i>Draw Smith</i>	5/13/02	

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	Applicant: Schuler et al. Filing Date: 8/14/00	Group: 2837

U.S. Patent Documents

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	A						
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	J						
	K						

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
TS	L	S62-194389	10.12.87	Japan			X	
TS	M	0607580 -	27.7.94	EPO			X	
TS	N	92/00559 -	9.1.92	PCT			X	
TS	O	JP4092691	25.3.92	Japan			X	
TS	P	JP7024147 -	27.1.95	Japan			X	

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
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Examiner	Date Considered	
<i>Erone Smith</i>	<i>5/13/02</i>	

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Filing Date: 8/14/00 Group: 2837

U.S. Patent Documents

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	A						
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Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
TS	L	JP4008381	13.1.92	Japan			X	
	M							
	N							
	O							
	P							

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
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Examiner <i>Draw Smith</i>	Date Considered <i>5/13/02</i>	

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